



US00RE49748E

(19) **United States**
(12) **Reissued Patent**
Lin et al.

(10) **Patent Number:** **US RE49,748 E**
(45) **Date of Reissued Patent:** ***Dec. 5, 2023**

(54) **IMAGE SENSOR AND LIGHT SOURCE DRIVER INTEGRATED IN A SAME SEMICONDUCTOR PACKAGE**

17/89 (2013.01); *H04N 13/254* (2018.05);
H04N 13/286 (2018.05); *H04N 25/705*
(2023.01); *H04N 25/75* (2023.01); *H01L*
27/14643 (2013.01); *H01L 2224/16145*
(2013.01); *H01L 2224/16225* (2013.01);

(71) Applicant: **GOOGLE LLC**, Mountain View, CA (US)

(Continued)

(72) Inventors: **Cheng-Yi Andrew Lin**, Mountain View, CA (US); **Clemenz Lenard Portmann**, Los Altos Hills, CA (US)

(58) **Field of Classification Search**

None
See application file for complete search history.

(73) Assignee: **GOOGLE LLC**, Mountain View, CA (US)

(56) **References Cited**

U.S. PATENT DOCUMENTS

(*) Notice: This patent is subject to a terminal disclaimer.

5,345,435 A * 9/1994 Yamasaki G11B 7/24079
6,831,688 B2 * 12/2004 Lareau G01J 3/02
348/272

(21) Appl. No.: **17/225,813**

(Continued)

(22) Filed: **Apr. 8, 2021**

FOREIGN PATENT DOCUMENTS

Related U.S. Patent Documents

Reissue of:

(64) Patent No.: **10,257,455**
Issued: **Apr. 9, 2019**
Appl. No.: **15/426,561**
Filed: **Feb. 7, 2017**

CN 102685534 A 9/2012
CN 103777750 A 5/2014
CN 104025295 A 9/2014

OTHER PUBLICATIONS

U.S. Applications:

(63) Continuation of application No. 14/579,825, filed on Dec. 22, 2014, now Pat. No. 9,581,696.

European Office Action dated Feb. 2, 2021 for European Application No. 15873893.0, 7 pages.

(Continued)

(51) **Int. Cl.**

H04N 5/378 (2011.01)
G01S 17/08 (2006.01)
H04N 25/13 (2023.01)
H04N 13/254 (2018.01)
H04N 13/286 (2018.01)

Primary Examiner — Yuzhen Ge

(Continued)

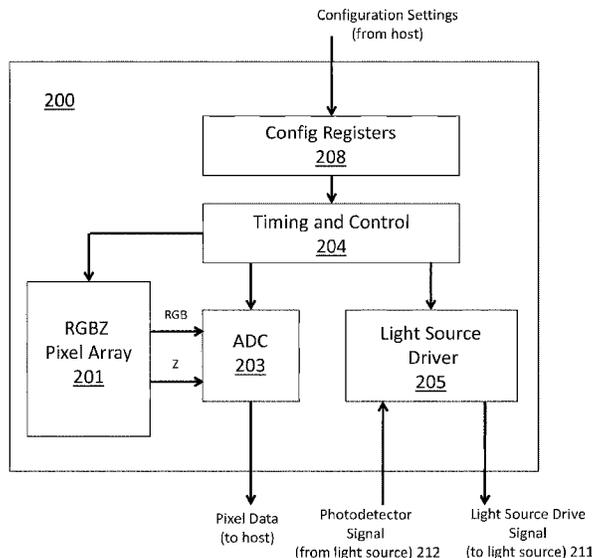
(52) **U.S. Cl.**

CPC *H04N 25/134* (2023.01); *G01S 7/4813* (2013.01); *G01S 7/4816* (2013.01); *G01S 17/08* (2013.01); *G01S 17/86* (2020.01); *G01S*

(57) **ABSTRACT**

An apparatus is described that includes an image sensor and a light source driver circuit integrated in a same semiconductor chip package. The image sensor includes visible light pixels and depth pixels. The depth pixels are to sense light generated with a light source drive signal. The light source drive signal is generated with the light source driver circuit.

23 Claims, 13 Drawing Sheets



(51) **Int. Cl.**
G01S 17/86 (2020.01)
H04N 25/705 (2023.01)
H04N 25/75 (2023.01)
G01S 7/481 (2006.01)
G01S 17/89 (2020.01)
H01L 27/146 (2006.01)

(52) **U.S. Cl.**
CPC *H01L 2924/15311* (2013.01); *H01L 2924/16151* (2013.01); *H01L 2924/16152* (2013.01)

(56) **References Cited**

U.S. PATENT DOCUMENTS

7,274,393 B2* 9/2007 Acharya H04N 5/33
250/226
7,636,150 B1 12/2009 McCauley et al.
7,830,442 B2 11/2010 Griffiths et al.
7,936,038 B2 5/2011 Jeong et al.
7,990,636 B2 8/2011 Park et al.
8,027,107 B2 9/2011 Hwang et al.
8,116,018 B2 2/2012 Park et al.
8,125,367 B2 2/2012 Ludwig
8,159,762 B2 4/2012 Lim et al.
8,218,016 B2 7/2012 Park et al.
8,320,621 B2 11/2012 McEldowney
8,645,099 B2* 2/2014 Min G01S 17/10
356/360
9,001,220 B2 4/2015 Kim
9,182,490 B2* 11/2015 Velichko H01L 27/14875
9,247,109 B2* 1/2016 Wang H04N 5/144
9,829,983 B2 11/2017 Park et al.
2004/0169749 A1* 9/2004 Acharya H04N 5/33
348/279
2006/0221250 A1 10/2006 Rossbach et al.
2008/0157250 A1 7/2008 Yang et al.
2010/0265316 A1* 10/2010 Sali H04N 13/254
348/46
2011/0157353 A1* 6/2011 Takayama G01C 11/26
348/135
2011/0194007 A1 8/2011 Kim et al.
2011/0199602 A1* 8/2011 Kim G01C 3/08
257/225
2011/0202310 A1 8/2011 Min et al.
2012/0036121 A1 2/2012 Jitkoff et al.
2012/0037705 A1* 2/2012 Mohideen G06T 7/62
382/103
2012/0134598 A1* 5/2012 Ovsiannikov G01S 7/4816
382/217
2012/0173184 A1* 7/2012 Ovsiannikov G01S 17/08
702/97
2012/0194477 A1 8/2012 Krah
2012/0206633 A1* 8/2012 Huo H04N 25/745
348/E3.016
2012/0224028 A1* 9/2012 Park G03F 7/40
250/206
2012/0242975 A1* 9/2012 Min G01B 11/22
356/5.03
2013/0026384 A1* 1/2013 Kim G01S 17/89
250/393
2013/0026859 A1 1/2013 Bae et al.
2013/0134470 A1 5/2013 Shin
2013/0176552 A1 7/2013 Brown et al.
2013/0201288 A1* 8/2013 Billerbeck G01S 7/4868
348/46
2013/0221470 A1 8/2013 Kinsman et al.
2013/0277533 A1* 10/2013 Olsen H04N 13/214
250/208.1
2013/0335725 A1* 12/2013 Hardegger G01S 17/023
356/5.1
2014/0009648 A1* 1/2014 Kim H04N 5/351
348/272

2014/0104391 A1* 4/2014 Kim H04N 13/257
348/46
2014/0111423 A1 4/2014 Park et al.
2014/0118493 A1* 5/2014 Sali H04N 13/254
348/43
2014/0204250 A1* 7/2014 Kim H04N 5/37455
348/294
2014/0240492 A1 8/2014 Lee
2014/0253758 A1* 9/2014 Metz G01S 17/89
348/231.99
2014/0347509 A1 11/2014 Venkataraman et al.
2015/0156428 A1* 6/2015 Uchida H04N 25/75
348/294
2015/0156434 A1* 6/2015 Luo A61B 5/0084
250/208.1
2015/0193934 A1* 7/2015 Fuchikami G01C 3/08
348/142
2015/0193938 A1* 7/2015 Freedman G06T 7/593
382/154
2015/0292884 A1* 10/2015 Fuchikami H04N 23/62
348/135
2015/0348906 A1* 12/2015 Park H01L 23/49827
257/774
2016/0100153 A1* 4/2016 Jeon H04N 13/296
348/46
2016/0127715 A1* 5/2016 Shotton G06V 40/11
348/46
2016/0142701 A1* 5/2016 Jeon H04N 13/271
348/46
2020/0236342 A1* 7/2020 Van Nieuwenhove
H04N 13/257

OTHER PUBLICATIONS

Extended European Search Report dated Mar. 11, 2022 for European Application No. 21188603.1, 11 pages.
Lucid Vision Labs, “Better Time of Flight: Sony DepthSense 3D Sensor Explained”, 12 pages; retrieved from the Internet on Apr. 6, 2021, URL: <https://thinklucid.com/tech-briefs/sony-depthsense-how-it-works/>.
European Office Action dated Nov. 23, 2022 for European Application No. 15873893.0, 8 pages.
Extended European Search Report issued in European Application No. 15873893.0, dated Jun. 29, 2018, 8 pages.
CN Office Action issued in Chinese Application No. 201580036250.3, dated Aug. 30, 2018, 15 pages (English translation).
PCT/US2015/056908—International Search Report and Written Opinion, dated Jan. 29, 2016, 14 pages.
‘gamasutra.com’ [online] “The Science Behind Kinects or Kinect 1.0 versus 2.0,” Daniel Lau, Nov. 27, 2013, [retrieved on Feb. 28, 2018] Retrieved from Internet: URL<https://www.gamasutra.com/blogs/DanielLau/20131127/205820/The_Science_Behind_Kinects_or_Kinect_10_versus_20.php> 7 pages.
‘newatlas.com’ [online] Hands-on with the Creative Senz3D, Adam Williams, Sep. 6, 2013, [retrieved on Mar. 13, 2018] Retrieved from Internet: URL<<https://newatlas.com/hands-on-with-the-creative-senz3d/28975/>> 27 pages.
‘www.adept.net.au’ [online] “SR4500 Data Sheet,” Mesa Imaging, Available on or before Apr. 4, 2015, [retrieved on Mar. 13, 2018] Retrieved from Internet: URL<<http://www.adept.net.au/cameras/Mesa/pdf/SR4500.pdf>> 4 pages.
‘www.adept.net.au’ [online] “Swiss Ranger SR4000,” Available on or before Mar. 25, 2012 [retrieved on Mar. 14, 2018] Retrieved from Internet: URL<<http://www.adept.net.au/cameras/Mesa/SR4000.shtml>> 4 pages.
‘www.blogs.microsoft.com’ [online] “Collaboration, expertise produce enhanced sensing in Xbox One,” Jeffery Meisner, Oct. 2, 2013, [retrieved on Mar. 15, 2018] Retrieved from Internet: URL<<https://blogs.microsoft.com/blog/2013/10/02/collaboration-expertise-produce-enhanced-sensing-in-xbox-one/>> 11 pages.
‘www.bloomberg.com’ [online] “Sony’s Big Bet on 3D Sensors that can See the World,” Yuji Nakamura, Oct. 25, 2017, [retrieved on

(56)

References Cited

OTHER PUBLICATIONS

Feb. 27, 2018] Retrieved from Internet: URL<<https://www.bloomberg.com/news/articles/2017-10-24/sony-s-big-bet-on-sensors-that-can-see-the-world>> 6 pages.

'www.electronicdesign.com' [online] "How Microsoft's PrimeSense-based Kinect Really Works," William Wong, Mar. 16, 2011, [retrieved on Feb. 28, 2018] Retrieved from Internet: URL<<http://www.electronicdesign.com/embedded/how-microsoft-s-primesense-based-kinect-really-works>> 15 pages.

'www.engadget.com' [online] "Intel announces Creative Sens3D Peripheral Camera at Computex 2013," Myriam Joire, Jun. 4, 2013, [retrieved on Mar. 13, 2018] Retrieved from Internet URL<<https://www.engadget.com/2013/06/04/intel-announces-creative-depth-vision-camera-at-computex-2013>> 9 pages.

'www.roborealm.com' [online] "Creative Sens3D," Available on or before Feb. 7, 2015, [retrieved on Mar. 12, 2018] Retrieved from Internet: URL<http://www.roborealm.com/help/Creative_Sens3D.php> 6 pages.

'www.sony.net' [online] "Sony Develops Back-Illuminated Time-of-Flight Image Sensor with the Industry's Smallest Pixel Pitch," Jun. 5, 2017, [retrieved on Feb. 21, 2018] Retrieved from Internet: URL<<https://www.sony.net/SonyInfo/News/Press/201706/17-059E/index.html>> 4 pages.

'www.sony.net' [online] "Sony Releases a Back-Illuminated Time-of-Flight Image Sensor," Dec. 19, 2017, [retrieved on Feb. 21,

2018] Retrieved from Internet: URL<<https://www.sony.net/SonyInfo/News/Press/201712/17-114E/index.html>> 4 pages.

'www.sony-depthsensing.com' [online] "SoftKinetic DS525 Datasheet Short Range Module," Available on or before Dec. 30, 2013, [retrieved on Mar. 19, 2018] Retrieved from Internet: URL<https://www.sony-depthsensing.com/Portals/0/Documents/PDF/WEB_20131230_SK_DS525_Datasheet_V2.1.pdf> 2 pages.

'www.ti.com' [online] "OPT8241 3D Time-of-Flight (ToF) Sensor Evaluation Module," Available on or before Feb. 2, 2017, [retrieved on Mar. 14, 2018] Retrieved from Internet: URL<<http://www.ti.com/tool/OPT8241-CDK-EVM#technicaldocuments>> 3 pages.

Horand et al. "An Overview of Depth Cameras and Range Scanners Based on Time-of-Flight Technologies," *Machine Vision and Applications Journal*, 27(7), Oct. 1, 2016, 18 pages.

Laukkanen. "Performance Evaluation of Time-of-Flight Depth Cameras," These submitted for Examination for the degree of Master of Science in Technology, Alto University School of Electrical Engineering, Nov. 23, 2015, 61 pages.

Li. "Time-of-Flight Camera—An Introduction," Texas Instruments Technical White Paper, SLOA190B, Jan. 2014, revised May 2014, 10 pages.

PR Newswire "SoftKinetic Provides 3D Imaging Solution for Intel All-in-One Computer Reference Design," Sep. 12, 2013, 2 pages.

Sarbolandi et al. "Kinect Range Sensing: Structured-Light versus Time-of-Flight Kinect," arXiv 1505.05459v1, May 20, 2015, 58 pages.

* cited by examiner

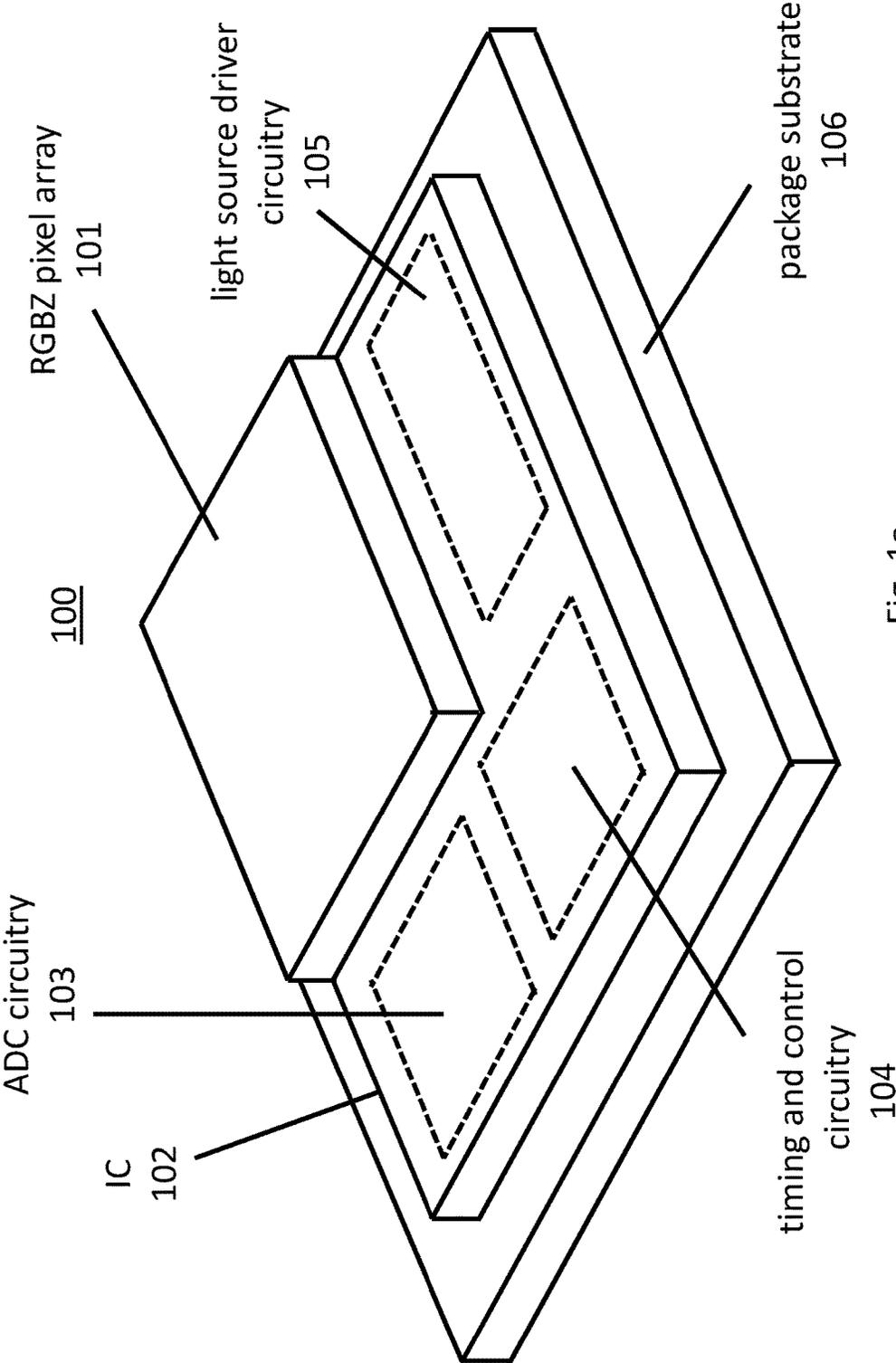


Fig. 1a

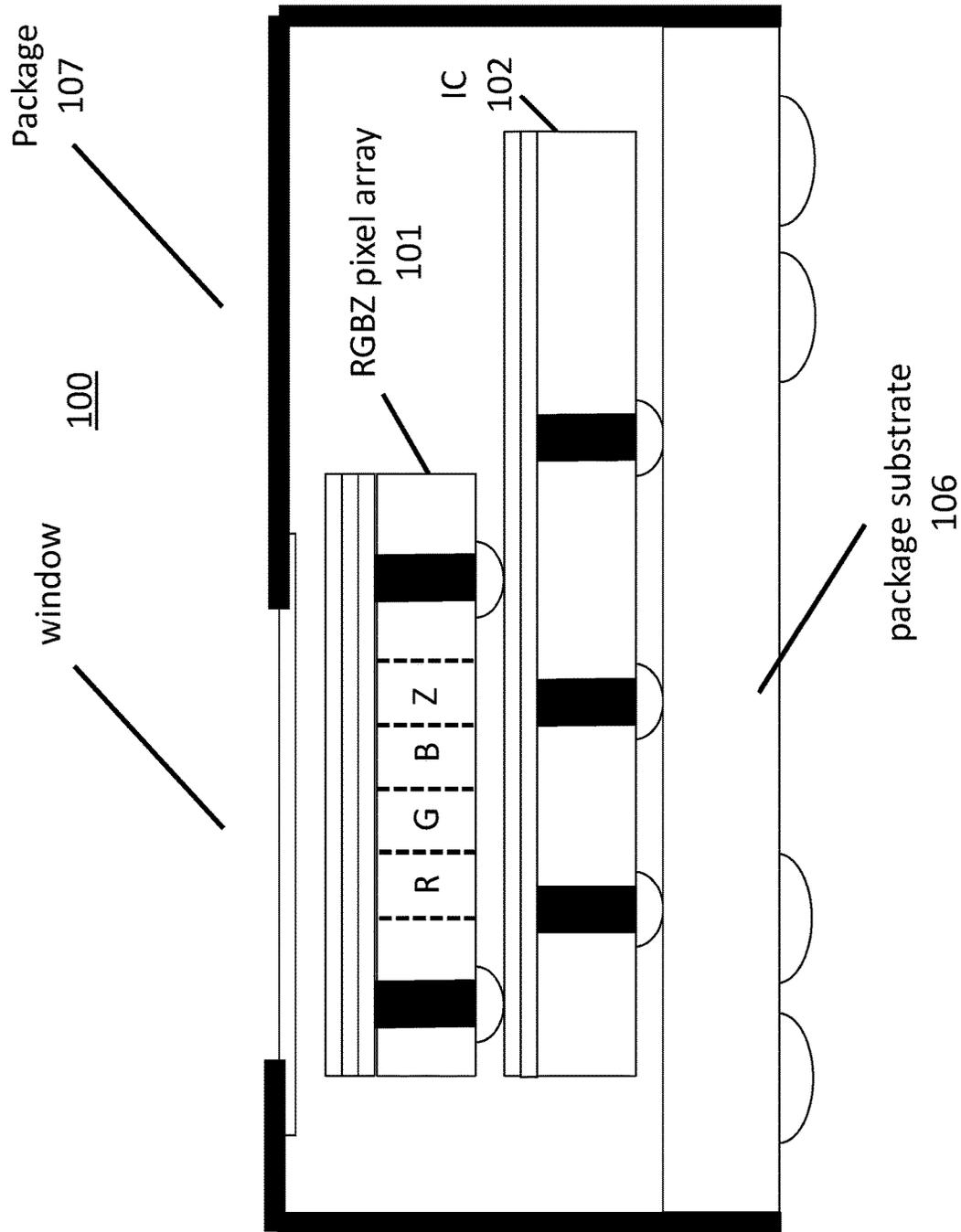


Fig. 1b

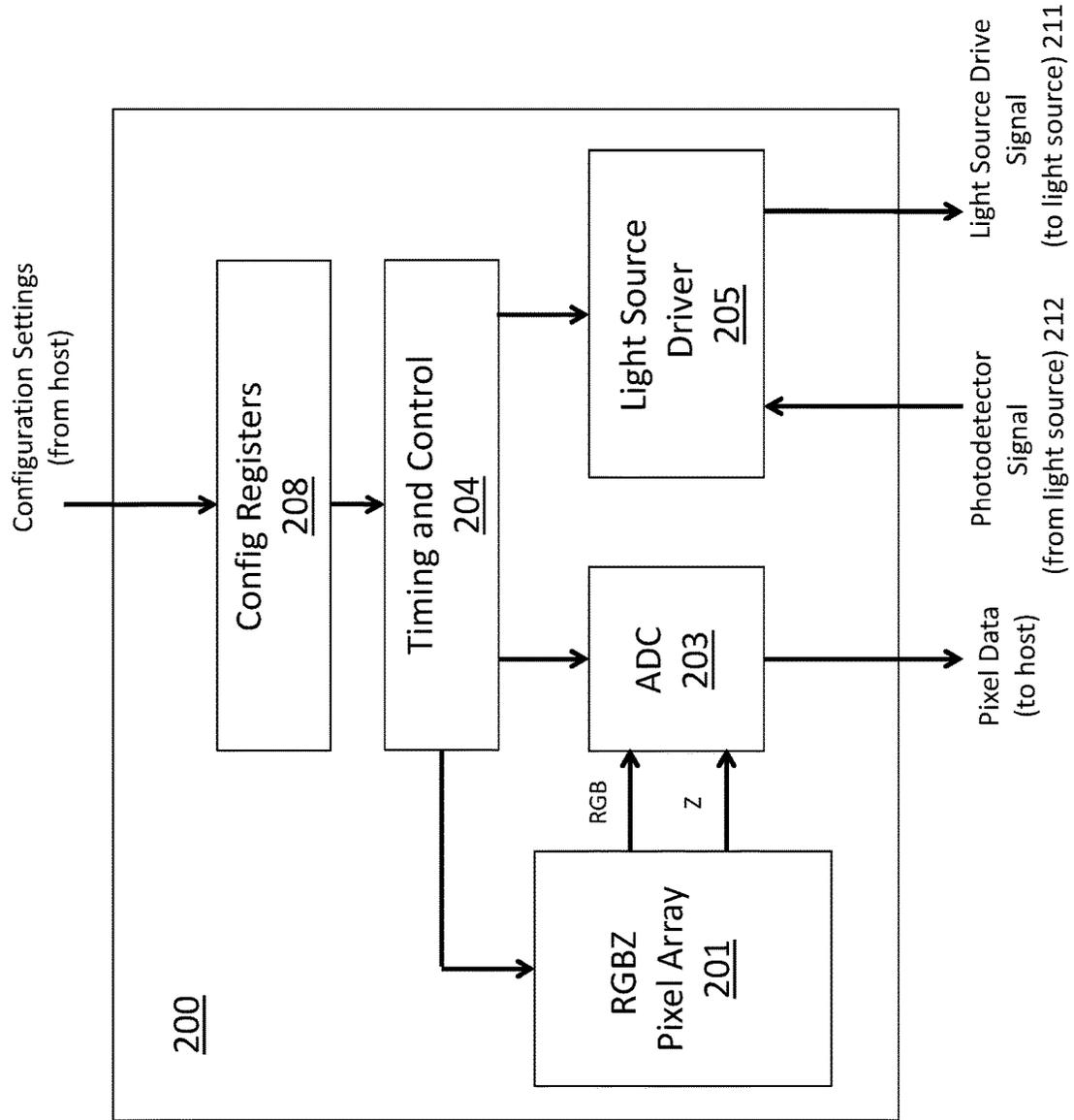


Fig. 2

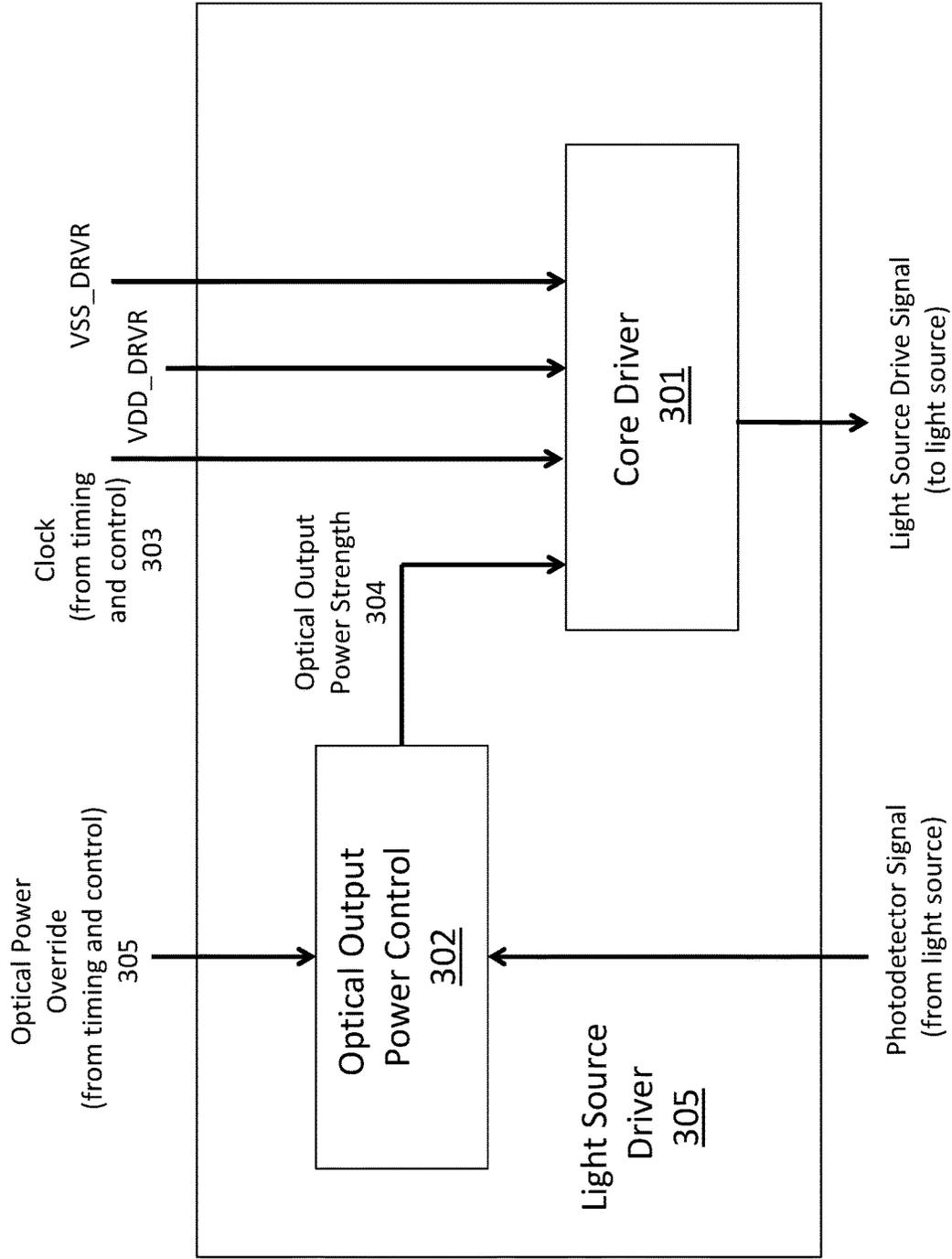


Fig. 3a

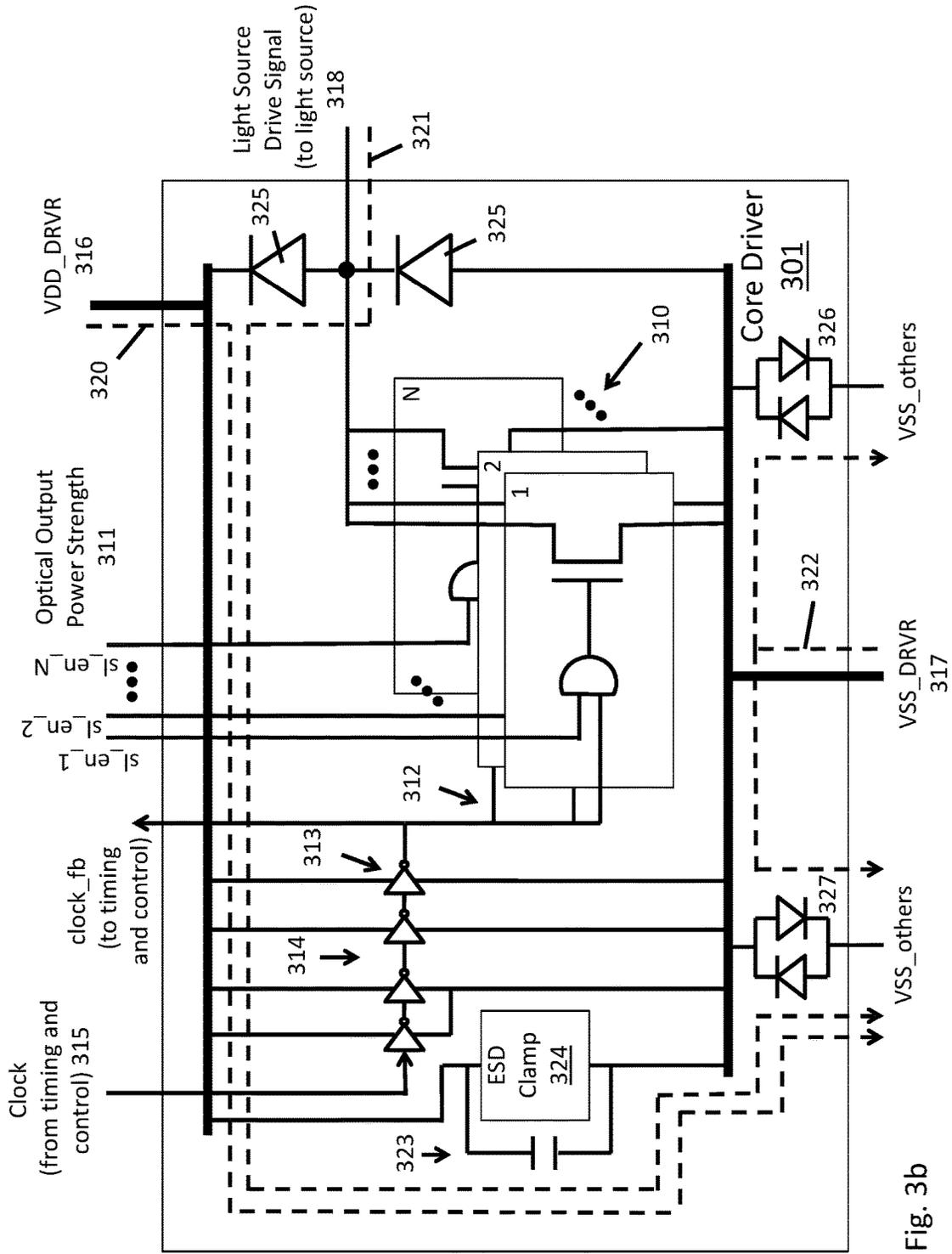


Fig. 3b

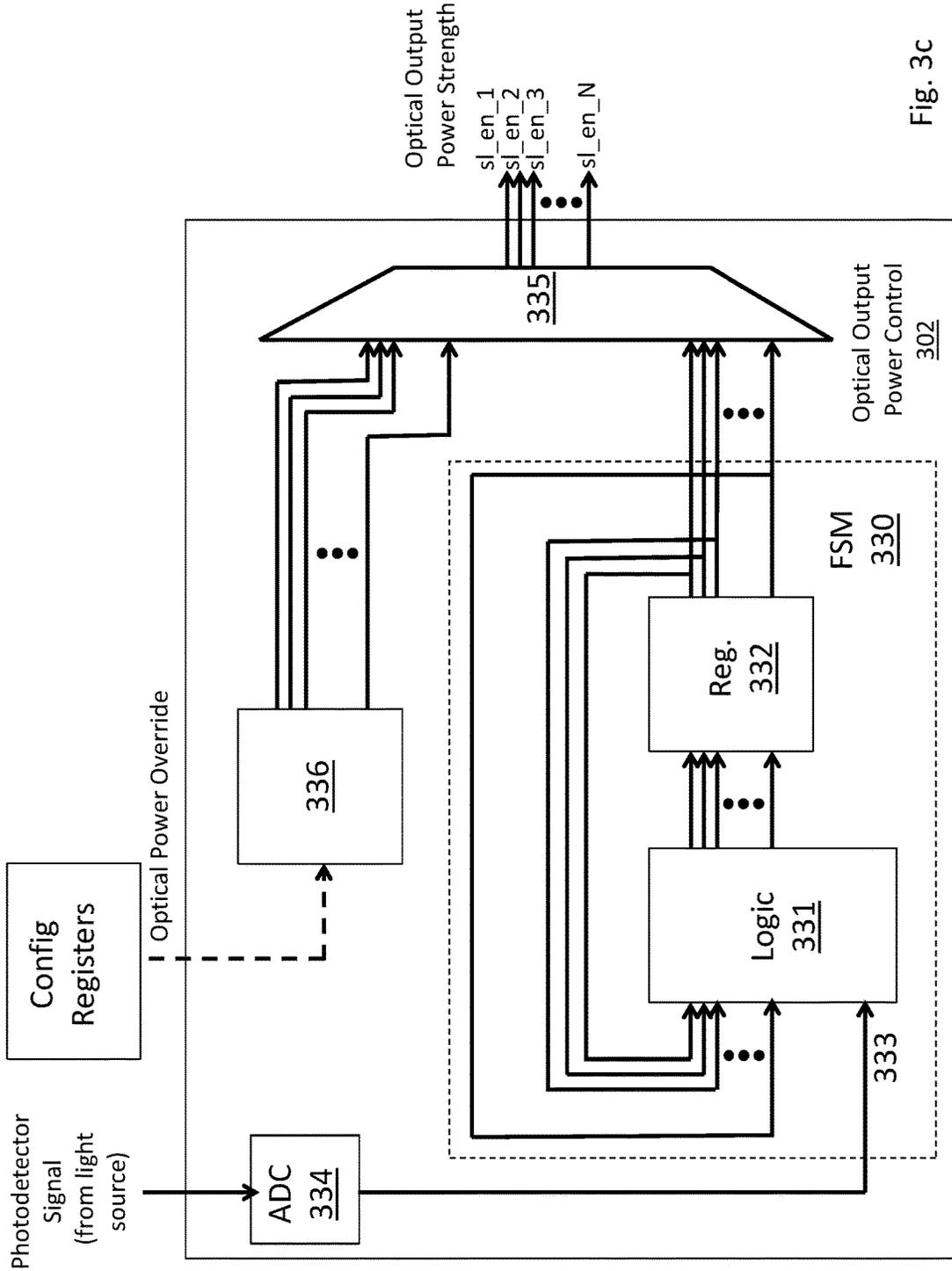


Fig. 3c

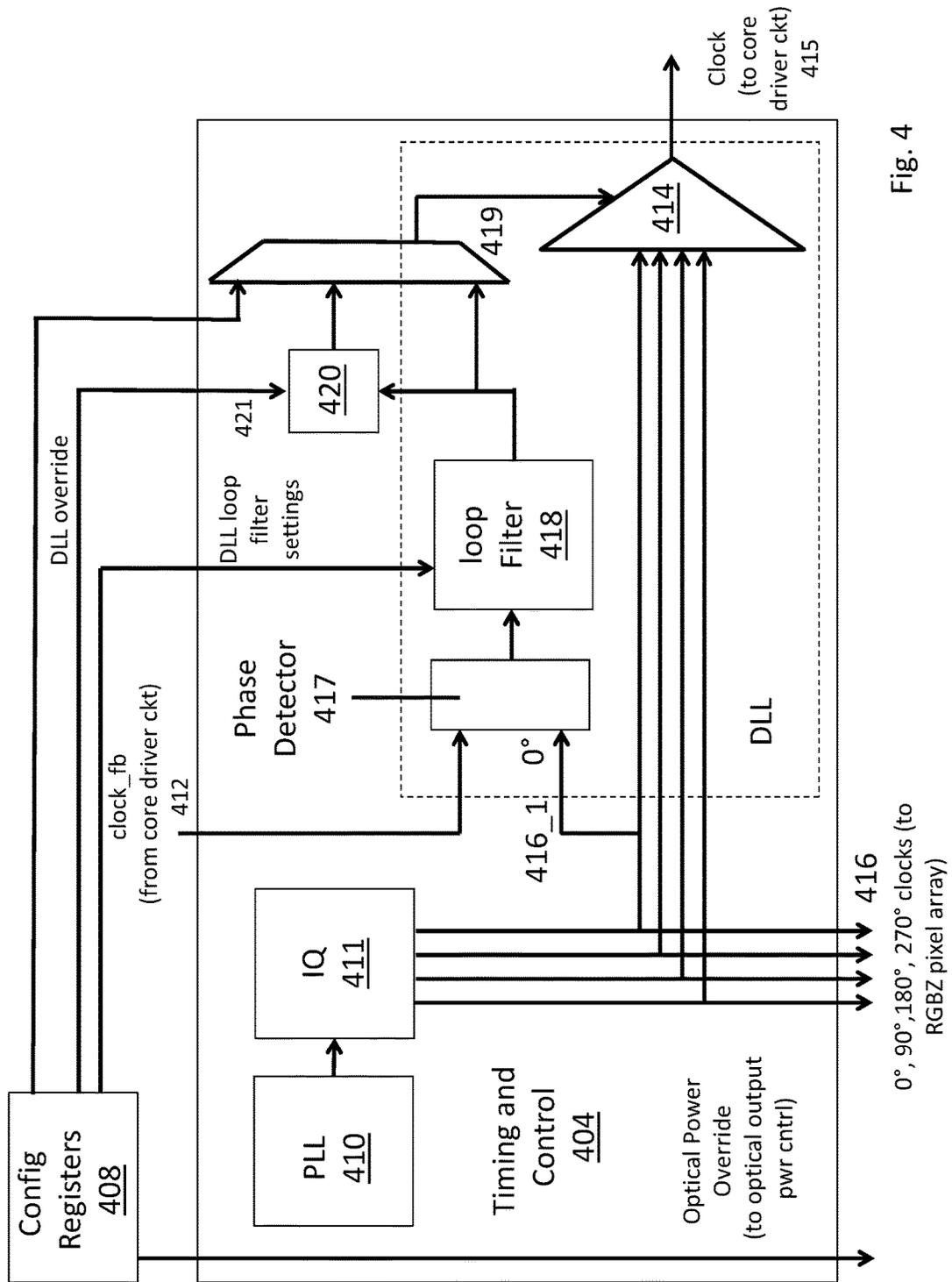


Fig. 4

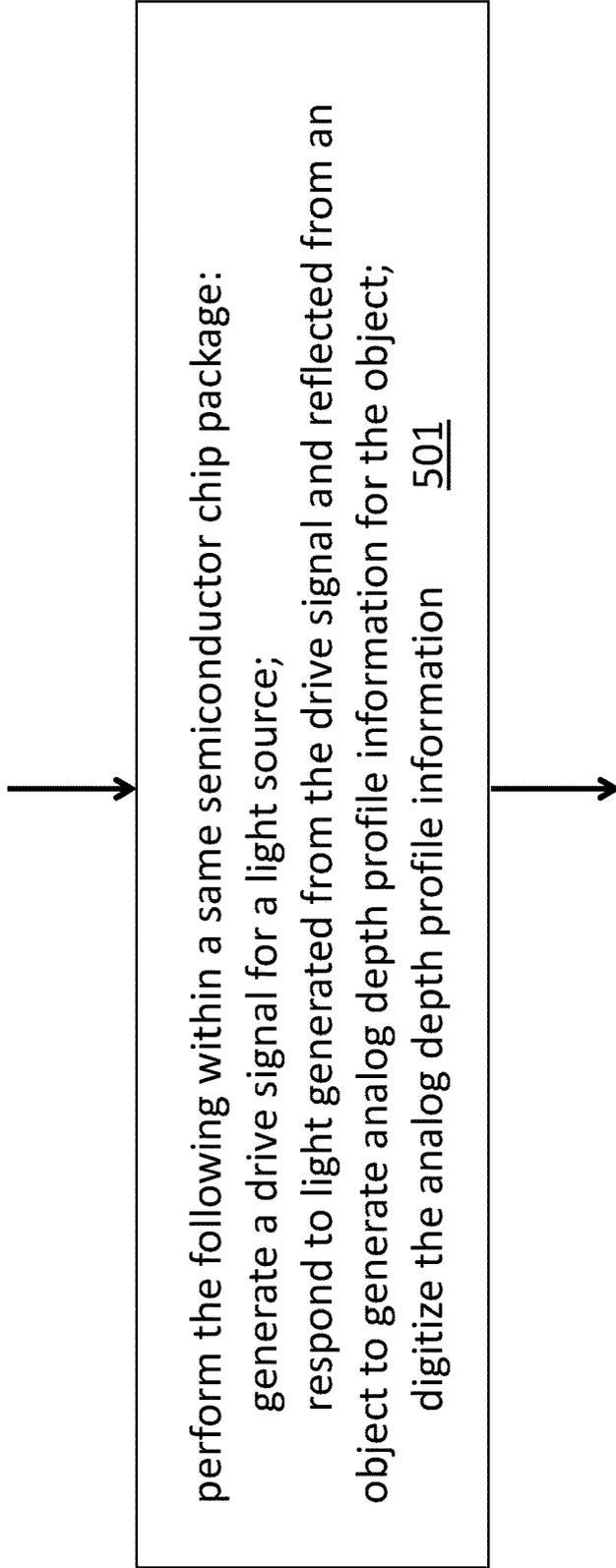


Fig. 5a

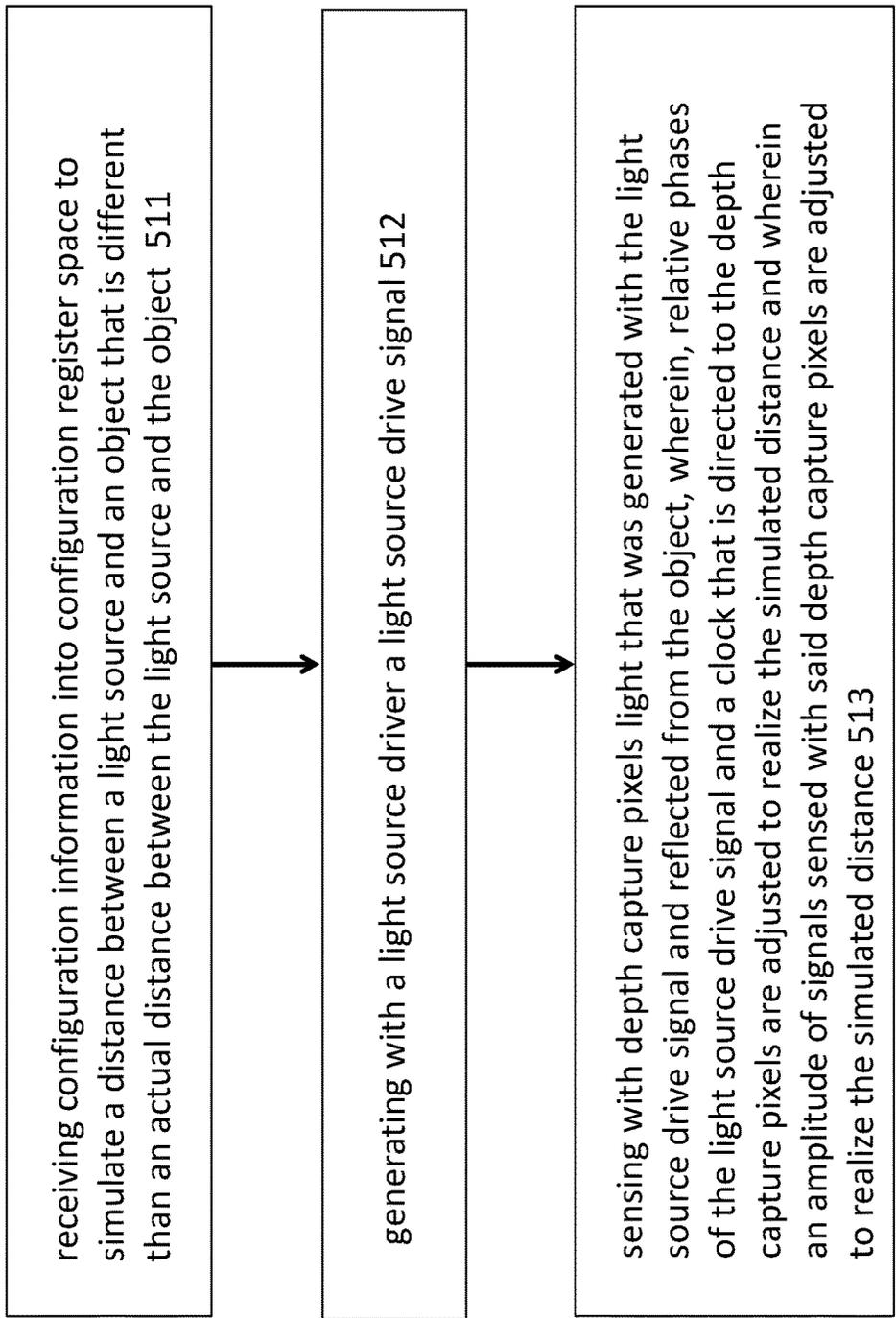


Fig. 5b

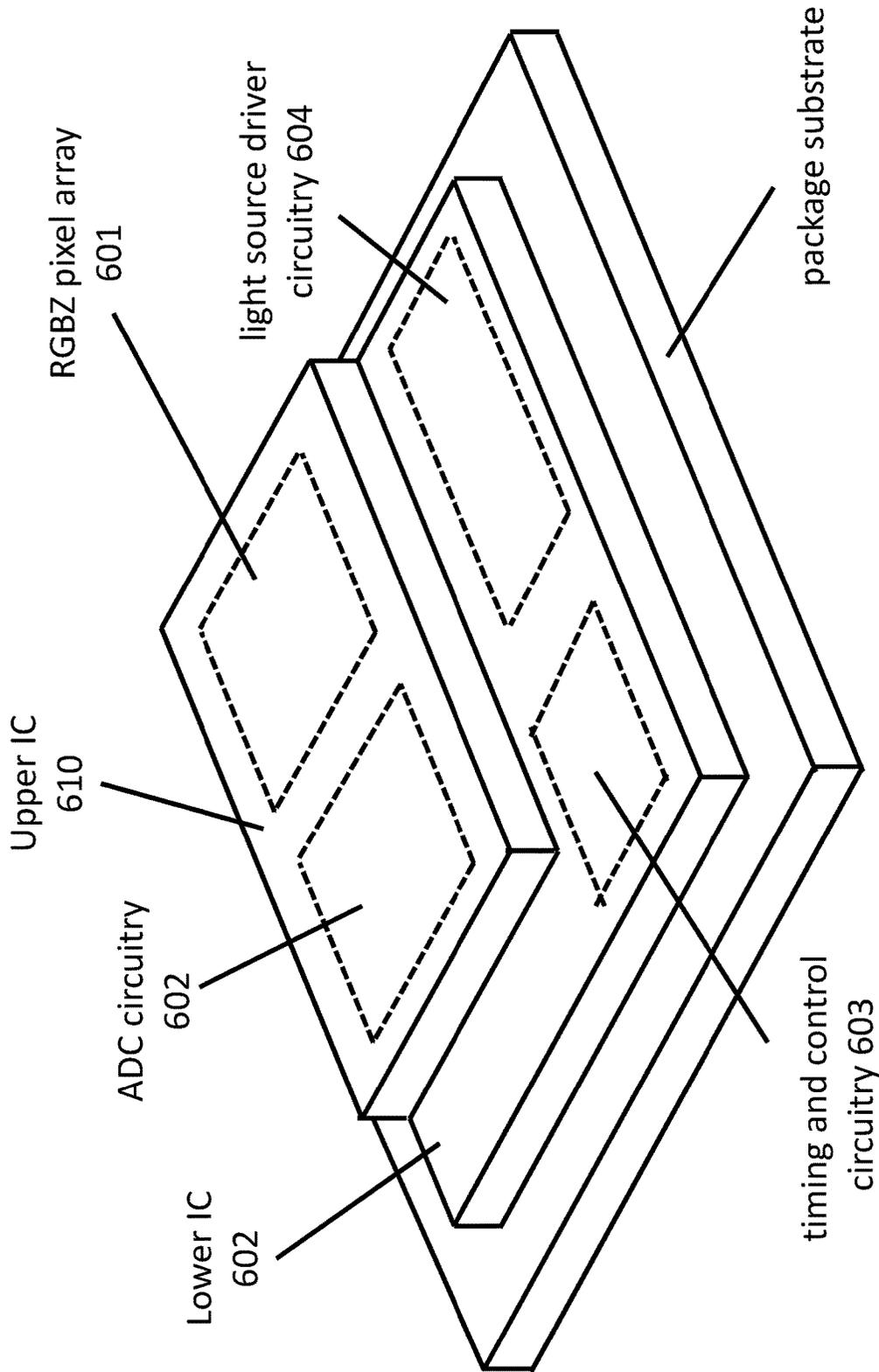


Fig. 6a

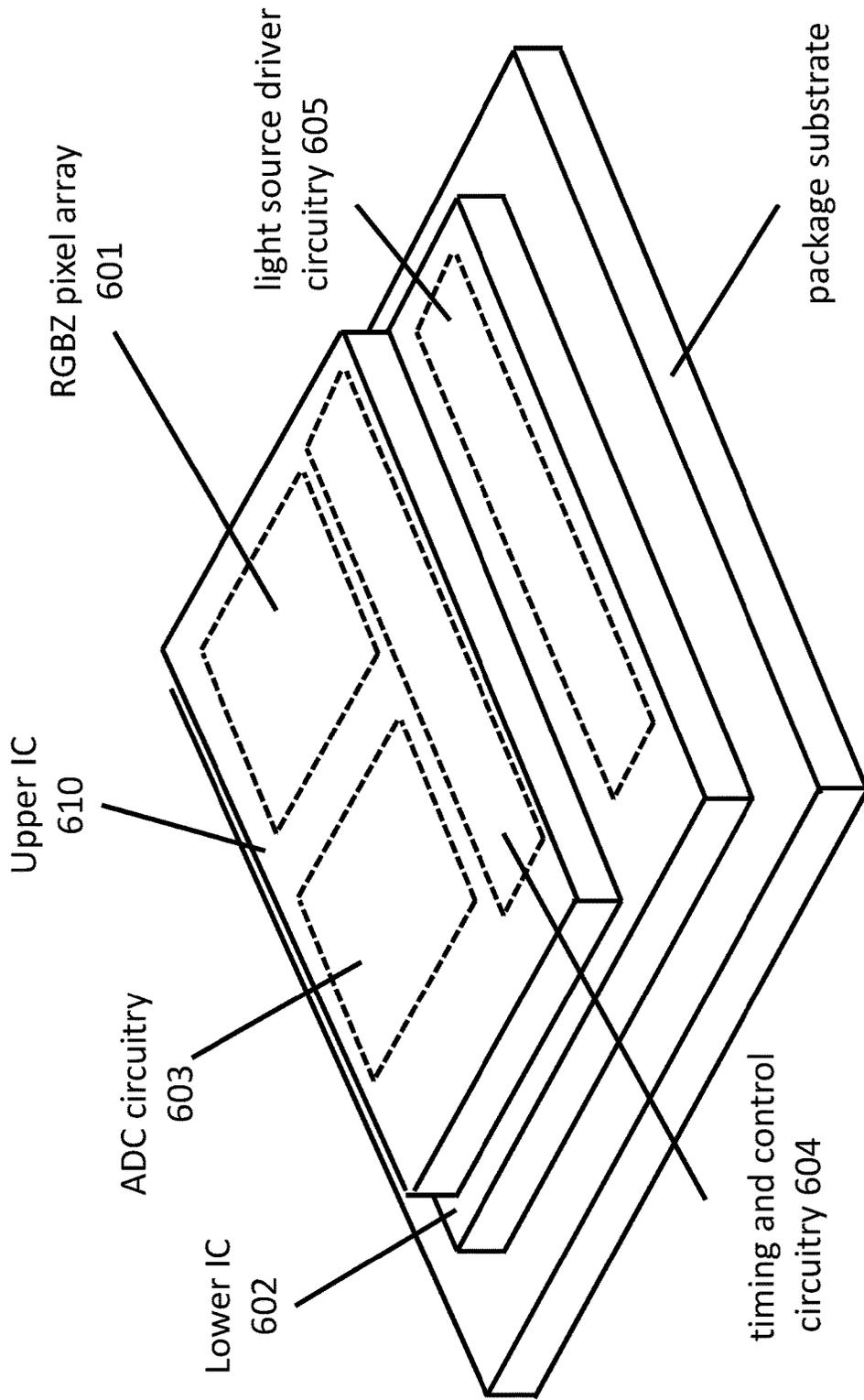


Fig. 6b

700

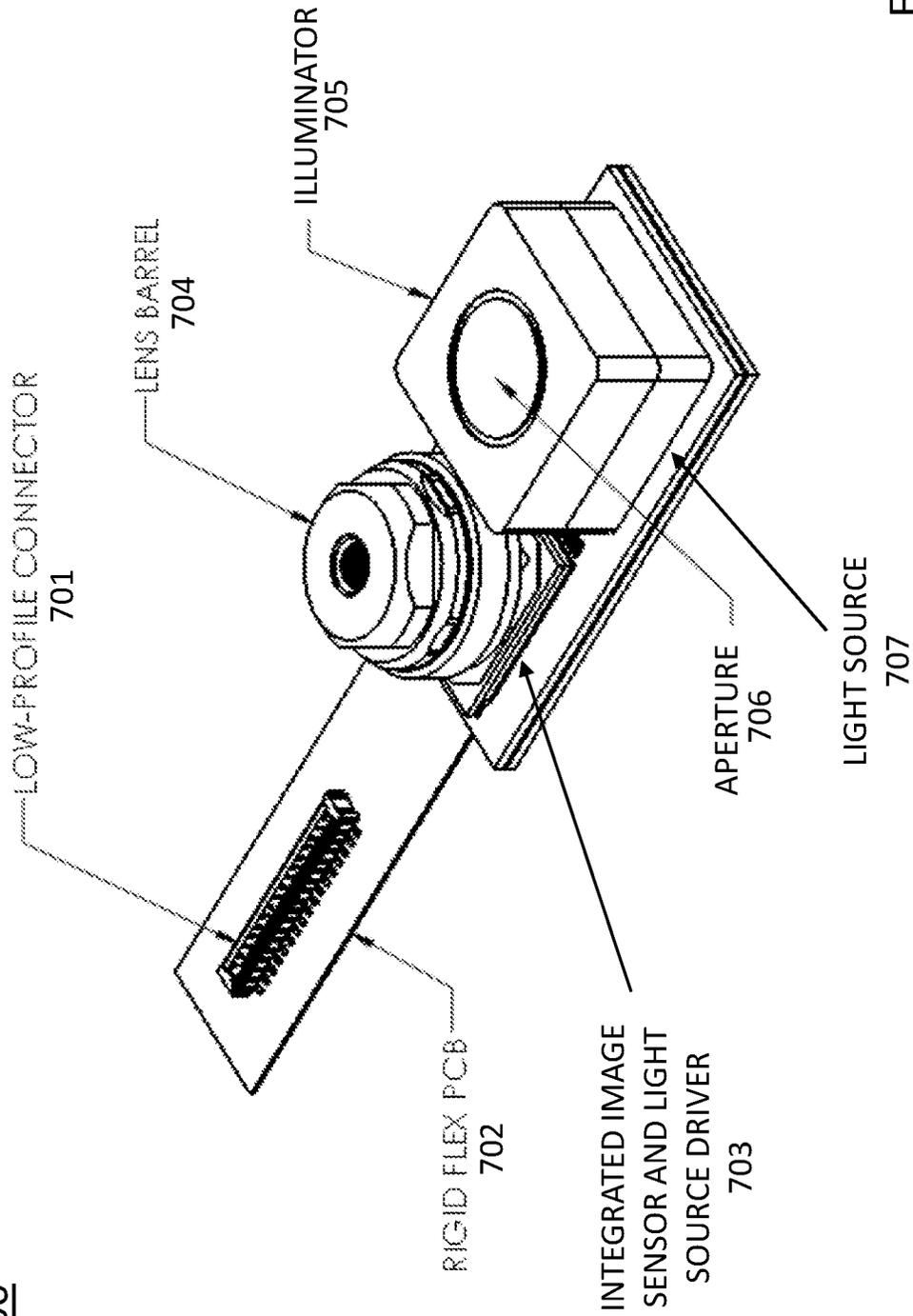


Fig. 7

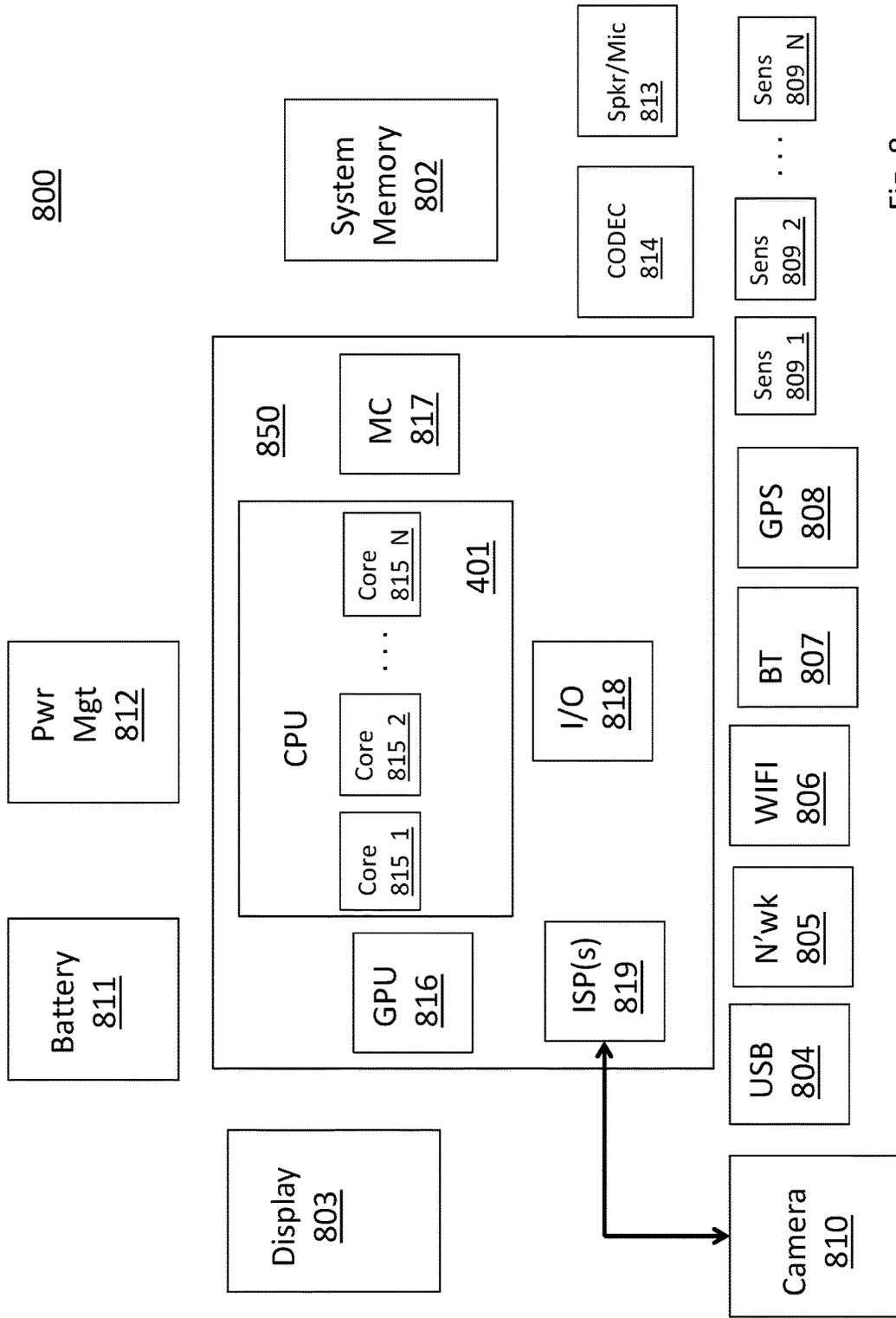


Fig. 8

**IMAGE SENSOR AND LIGHT SOURCE
DRIVER INTEGRATED IN A SAME
SEMICONDUCTOR PACKAGE**

Matter enclosed in heavy brackets [] appears in the original patent but forms no part of this reissue specification; matter printed in italics indicates the additions made by reissue; a claim printed with strikethrough indicates that the claim was canceled, disclaimed, or held invalid by a prior post-patent action or proceeding.

[RELATED CASES]

[This application is a continuation of and claims the benefit of U.S. patent application Ser. No. 14/579,825, titled "IMAGE SENSOR AND LIGHT SOURCE DRIVER INTEGRATED IN A SAME SEMICONDUCTOR PACKAGE", filed Dec. 22, 2014, which is incorporated by reference in its entirety.]

CROSS-REFERENCE TO RELATED
APPLICATIONS

NOTICE: More than one reissue application has been filed for the reissue of U.S. Pat. No. 10,257,455. The reissue applications are U.S. patent application Ser. No. 17/225,813 (the present application) filed on Apr. 8, 2021 and U.S. Ser. No. 17/323,319 (a continuation reissue application claiming benefit of the present application) filed herewith.

This application is an application for reissue of U.S. Pat. No. 10,257,455, issued from U.S. patent application Ser. No. 15/426,561, filed on Feb. 7, 2017, which in turn is a continuation of U.S. patent application Ser. No. 14/579,825, filed on Dec. 22, 2014 (now U.S. Pat. No. 9,581,696).

FIELD OF THE INVENTION

The field of invention pertains generally to camera technology and, more specifically, to an image sensor and light source driver integrated in a same semiconductor package.

BACKGROUND

Many existing computing systems include one or more traditional image capturing cameras as an integrated peripheral device. A current trend is to enhance computing system imaging capability by integrating depth capturing into its imaging components. Depth capturing may be used, for example, to perform various intelligent object recognition functions such as facial recognition (e.g., for secure system un-lock) or hand gesture recognition (e.g., for touchless user interface functions).

One depth information capturing approach, referred to as "time-of-flight" imaging, emits light from a system onto an object and measures, for each of multiple pixels of an image sensor, the time between the emission of the light and the reception of its reflected image upon the sensor. The image produced by the time of flight pixels corresponds to a three-dimensional profile of the object as characterized by a unique depth measurement (z) at each of the different (x,y) pixel locations.

As many computing systems with imaging capability are mobile in nature (e.g., laptop computers, tablet computers, smartphones, etc.), the integration of a light source ("illuminator") into the system to achieve time-of-flight operation

presents a number of design challenges such as cost challenges, packaging challenges and/or power consumption challenges.

SUMMARY

An apparatus is described that includes an image sensor and a light source driver circuit integrated in a same semiconductor chip package. The image sensor includes visible light pixels and depth pixels. The depth pixels are to sense light generated with a light source drive signal. The light source drive signal is generated with the light source driver circuit.

An apparatus is described that includes, within a same semiconductor chip package, means for generating a drive signal for a light source, means for responding to light generated from the drive signal and reflected from an object to generate analog depth profile information for the object and means for digitizing the analog depth profile information.

FIGURES

The following description and accompanying drawings are used to illustrate embodiments of the invention. In the drawings:

FIG. 1a shows a depiction of an embodiment of an integrated image sensor and light source driver;

FIG. 1b shows another depiction of an embodiment of an integrated image sensor and light source driver;

FIG. 2 shows a system diagram of an integrated image sensor and light source driver;

FIG. 3a shows a system diagram of a light source driver;

FIG. 3b shows a diagram of a core light source driver;

FIG. 3c shows a diagram of an optical output power circuit;

FIG. 4 shows a diagram of a timing and control circuit;

FIG. 5a shows a first methodology performed by an integrated image sensor and light source driver;

FIG. 5b shows a second methodology performed by an integrated image sensor and light source driver;

FIG. 6a shows another embodiment of an integrated image sensor and light source driver;

FIG. 6b shows yet another embodiment of an integrated image sensor and light source driver;

FIG. 7 shows an embodiment of a 2D/3D camera system having an integrated image sensor and light source driver;

FIG. 8 shows an embodiment of a computing system having a 2D/3D camera system having an integrated image sensor and light source driver.

DETAILED DESCRIPTION

FIGS. 1a and 1b show different perspectives of an integrated image sensor and light source driver **100** that addresses some of the challenges referred to in the Background. As observed in FIGS. 1a and 1b, the integrated image sensor and light source driver **100** includes an RGBZ pixel array chip **101** that is stacked on an underlying integrated circuit **102** having analog-to-digital (ADC) circuitry **103**, timing and control circuitry **104** and light source driver circuitry **105**. The underlying integrated circuit **102** is mounted on a package substrate **106** such that the entirety of the pixel array **101** and the underlying integrated circuit **102** are contained within a same package **107**.

The RGBZ pixel array chip **101** includes different kinds of pixels, some of which are sensitive to visible light (red (R), green (G) and blue (B)) and others of which are

sensitive to IR light. The RGB pixels are used to support traditional “2D” visible image capture (traditional picture/taking) functions. The IR sensitive pixels are used to support 3D depth profile imaging using time-of-flight techniques.

A camera system having both traditional image capture and time-of-flight depth capture functions typically includes: 1) an illuminator (e.g., at least one laser, laser array, LED or LED array to generate the IR light for the time-of-flight system); 2) an RGBZ pixel array; 3) driver circuitry for the illuminator; and, 4) analog to digital conversion circuitry and timing and control circuitry that, together with the RGBZ pixel array, form a complete image sensor. Here, items 1) and 2) above can be viewed as the electro-optical components of the camera system and items 3) and 4) can be viewed as the supporting electronics for the electro-optical components. Notably, the integrated image sensor and light source driver **100** of FIGS. **1a** and **1b** integrate most if not all of items 2), 3) and 4) above in a single package **107** which, in turn, should provide for a cheaper and/or smaller form factor solution for these items as compared to prior art approaches.

For ease of drawing the ADC circuitry **103**, timing and control circuitry **104** and light source driver circuitry **105** are drawn not necessarily to scale and not showing any “underlap” beneath the pixel array **101**. It is conceivable that some solutions may opt to place some portion or the entirety of any of the ADC circuitry **103**, the timing and control circuitry **104** and the light source driver **105** beneath the pixel array **101**.

FIG. **1b** shows an embodiment of a cross section of the pixel array **101** stacked on the underlying semiconductor die **102**. As observed in FIG. **1b**, electrically conductive balls/bumps formed on the top surface of the underlying integrated circuit **102** are aligned to make contact with conductive balls/bumps formed on the lower surface of the pixel array **101**.

The balls/bumps on the lower surface of the pixel array **101** are connected to respective conductive vias within the pixel array substrate that electrically couple to respective traces formed within the metallization planes of the pixel array **101**. As is known in the art, the metallization planes of the pixel array **101** provide biasing and/or signaling to any transistors embedded in the upper surface of the pixel array substrate as well as provide the output analog sense signals generated by the pixel array’s pixels. The metallization planes may be part of a larger multilayer structure above the pixel array substrate that also includes filters (e.g., RGB filters for RGB pixels and IR filters for Z pixels) and micro-lenses.

The underlying IC **102** also includes through-substrate conductive vias that electrically connect its metallization layers to its underlying contact balls/bumps. Note that, as appropriate for any particular packaging technology, any ball/bump of a pair of contacting balls/bumps shown in FIG. **1b** may be replaced with a pad/land instead of a ball/bump. Balls/bumps/pads may be disposed as an array, around the periphery or other arrangement on its corresponding die’s surface. In an alternative approach, instead of a ball/bumps being formed on the lower side of the IC, the IC may include wire bond pads around its periphery and the IC may be electrically coupled to the package substrate by wire bonding from these pads to the surface of the underlying substrate.

The package substrate **107** may be made from any typical planar board technology (e.g., having alternatively layers of conductive and insulating planes, where the insulating

planes are composed of any of, e.g., FR4, ceramic, etc.). As observed in FIG. **1b**, the package substrate **107** also has conductive balls/bumps for electrical contact to the camera system into which the sensor and driver is integrated.

FIG. **2** shows a depiction of the system architecture **200** for integrated image sensor and light source driver **100** of FIGS. **1a** and **1b**. As observed in FIG. **2**, the light source driver circuitry **205** provides a drive signal **211** to the illuminator (not shown). The amplitude of the drive signal determines the optical power of the light emitted from the illuminator. In an embodiment, the illuminator includes a photo-detector that generates a higher amplitude signal as the optical intensity emitted by the illuminator increases. According to the system architecture **200** of FIG. **2**, the photo-detector signal **212** is received by the light source driver circuitry and incorporated into a controlled feedback loop to control the amplitude of the drive signal **211**.

The drive signal **211** may also be modulated, e.g., in the form of a sinusoidal or clock signal, to implement continuous wave illumination. Timing and control circuitry **204** provides the modulation signal to the light source driver circuitry **205**. In the case where the modulation signal is akin to a clock signal, one logic value of the clock signal corresponds to the illuminator being “on” while the other logic value corresponds to the illuminator being “off”. As such, the illuminator flashes light in an on-off-on-off fashion into the camera’s field of view. In various embodiments, the light source(s) of the illuminator may be arranged as an array of vertical cavity side emitting laser diodes (VCSELs) or light emitting diodes (LEDs) each coupled to a same anode terminal and a same cathode terminal (so that all VCSEL/LEDs of the array turn on and off together), and where, the drive signal **211** from the light source driver **205** is coupled to one of the anode or cathode of the array.

The “Z” pixels of the RGBZ pixel array **201** effectively perform “3D” time-of-flight depth measurements by generating charge as a function of the time between when the illuminator’s light was flashed “on” and when the flash’s reflected light is received at the sensor. The Z pixels receive clock signals from timing and control circuitry **204** that each have a known phase relationship with the illuminator’s clock signal. In one embodiment, there are four such clock signals (e.g., 0°, 90°, 180° and 270° quadrature arms) provided to each region of the pixel array **201** where a depth value is to be measured.

Here, Z pixels that are clocked by clocks of differing phase will collect different amounts of charge for a same light flash. Collected charge signals from differently clocked Z pixels in a same/proximate region of the sensor can be combined to generate a specific time-of-flight value for the sensor region. In a typical implementation, such combination is made by the host system (e.g., processor or applications processor) with an image signal processor. As such, the ADC circuitry **203** typically converts analog signals representing the charge collected by the individual Z pixels into digital values that are forwarded to the host system which subsequently calculates the depth information from the digitized pixel values. In other embodiments, various forms of image signal processing, including but not limited to the calculation of the depth information from the pixels may be performed by logic circuitry external to the host side (e.g., logic circuitry disposed on a same semiconductor chip that includes the image sensor or some other semiconductor chip included in the camera peripheral).

The RGB pixels of the RGBZ pixel array **201** are used for “2D” traditional image capture and are respectively sensitive to red, green and blue visible light within the camera’s field

5

of view. The ADC circuitry **203** likewise receives analog signals from the RGB pixels of the pixel array **201** and converts them to digital values that are forwarded to the host system. Although a common approach includes RGB pixels for the visible image capture, other embodiments may use different colored pixel schemes (e.g., Cyan, Magenta and Yellow).

The timing and control circuit **204** generates respective clock signals that are sent to the light source driver **205**, the pixel array **201** and the ADC circuitry **203**. Other signals, such as control signals generated in response to commands or configuration information that is received from the host system and stored in configuration registers **208** may also be generated from the timing and control circuitry. For ease of drawing purposes, FIGS. 1a and 1b do not depict the configuration registers **208** of FIG. 2.

Notably, because traditional image sensors do not have an integrated illuminator driver, traditional image sensor timing and control circuits only generate control and clocking signals for image sensor components (notably, the ADC circuitry **203** and the pixel array **201**). By contrast, the timing and control circuit **204** in various embodiments may be considered unique because, apart from providing clock and control signals used for image reception, it also generates timing and control circuitry for a light source drive circuit **205**. Note that, architecturally speaking, image sensor timing and control circuitry that also generates timing and/or control signals for a light source drive circuit is believed to be unique whether or not the light source drive circuit is integrated on the same semiconductor chip with the image sensor timing and control circuitry.

FIGS. 3a through 3c show aspects of the laser driver circuit **205** of FIG. 2. As observed in FIG. 3a, the laser driver circuit **305** can be viewed as including a core driver circuit **301** and a power control circuit **302**. The core driver circuit **301** provides the drive current that is driven through the light source. The core driver circuit **301** also receives a waveform (e.g., clock signal, sinusoid, etc.) as a modulation signal **303** for the drive signal. As discussed above, the modulation signal determines the timing of the manner in which the light source is flashed.

The optical output power control circuit **302** provides to the core driver circuit **301** a signal **304** that specifies the magnitude of the drive signal. The magnitude of the drive signal, in turn, determines the optical power emitted by the light source. In an embodiment, the power control circuit **302** also receives the photodiode current (or an indication of the RMS or average value thereof) from the light source array. As discussed in more detail below, the photodiode current provides an indication of the optical output power presently being emitted by the light source, and, the optical output power control circuit **302** uses the photodetector current as an input into a controlled feedback loop. The optical output power control circuit **302** may also receive an override optical power value that overrides the aforementioned feedback loop for, e.g., testing or manufacturing environments. Each of these features will be described more thoroughly immediately below.

FIG. 3b shows an embodiment of the core driver circuit **301**. As observed in FIG. 3a, the core driver **301** includes a plurality of driver "slices" **310** each having a drive transistor and an enable gate. In order to establish a specific drive strength for the core driver **301**, the core driver **301** is configured to receive input information **311** that defines the number of the slices to activate. According to the specific embodiment of FIG. 3, the input information takes the form

6

of a bus with each wire of the bus corresponding to an active/inactive signal for a particular slice.

Each of the driver slices also include a clock signal input **312** to receive a digital clock signal. The clock signal modulates the current being pulled by the drive transistors of the enabled slices such that the light source flashes in an on-off-on-off sequence as discussed above. Because the set of driver slices present a large input capacitance at the clock signal input, an inverting drive buffer **313** having sufficient output current drive strength to drive the clock signal input capacitance is coupled to the clock signal input **312**. As observed in FIG. 3b, the inverting drive buffer **313** and preceding buffer/inverters **314** form a fan-up chain to increase the drive strength of the drive buffer **313**. A fan-up chain includes a series of buffers/inverters where each buffer/inverter in the chain provides greater output drive strength than its preceding buffer/inverter. Thus, per buffer/inverter output drive strength is essentially amplified moving forward in the chain. In the embodiment of FIG. 3b, four inverters produce sufficient drive strength at the output of inverting drive buffer **313**.

The core driver circuit **301** includes special, isolated upper and lower power rails VDD_DRVR **316** and VSS_DRVR **317**. In an embodiment, each of these power rails **316**, **317** is supplied by a respective external, off-die voltage regulator (not shown) that is dedicated to the core driver circuit. Multiple I/Os (balls/pads) of the core driver's semiconductor chip are reserved for each of the rails to ensure low resistance between the regulators and the integrated sensor/driver package.

In an embodiment where the semiconductor die is wire bonded to the package substrate, multiple pads of the IC are reserved for both rails, and each of the multiple pads is double bonded to the package substrate (again, to reduce resistance between the package substrate and the semiconductor chip). Here, as the core driver circuit may drive significant amounts of current, keeping resistance low along the supply rails keep power dissipation low through the IC wire bonds.

The core driver circuit **301** also includes other circuitry to provide for electro-static discharge (ESD) protection and isolation from the other circuits on the semiconductor chip. With respect to ESD protection, it is pertinent to recognize that any node of the core driver circuit **301** that is connected to a package I/O may receive a large amount of ESD charge. These nodes include any of the VDD_DRVR **316**, VSS_DRVR **317** and the light source drive signal output node **318**. In order to protect the core driver circuit **301**, the core driver circuit **301** should include a current pathway out of the circuit **301** from any of these nodes **316**, **317**, **318** should they receive electro-static discharge.

FIG. 3b shows a first current path **320** out of the circuit **310** if the VDD_DRVR node **316** is charged, a second current path **321** out of the circuit **310** if the drive signal output **318** is charged and third current path(s) **322** out of the circuit if the VSS_DRVR node **317** is charged. These paths **320**, **321**, **322** flow into "other" VSS nodes of the semiconductor die (e.g., VSS nodes used by circuits of the semiconductor die other than the core driver **301**).

Note that some of these paths **320**, **322** flow through a bypass capacitor **323** that resides between the VDD_DRVR and VSS_DRVR nodes. The bypass capacitor **323** and an ESD clamp circuit **324** also help prevent the generation of a large, damaging voltage difference across the VDD_DRVR **316** and VSS_DRVR **317** nodes as a consequence of being

charged. Likewise, a large voltage is prevented from being generated at the light source drive output by protective clamping diodes **325**.

The core driver circuit **301**, in driving the light source, may be asked to drive large amounts of current and therefore may have the propensity to act as a noise source for other circuits on the semiconductor die or otherwise within the package. As such, the core driver circuit **301** also includes a number of isolation features.

A first isolation feature is the separate VDD_DRVR and VSS_DRVR supply rails **316**, **317** discussed above that are driven by their own voltage regulators (i.e., in an embodiment the voltage regulators do not drive other circuits besides the VDD_DRVR and VSS_DRVR rails respective rails). A second isolation feature is the presence of isolation clamps **326**, **327** that reside at both points of contact between the core driver circuit and the other VSS nodes. Here, the ESD protection paths out of the core driver circuit effectively couple the VSS_DRVR node to the other VSS nodes. Such coupling can permit noise generated by the core driver circuit **301** to reach other circuits within the semiconductor die. The isolation clamps **326**, **327** help squelch such noise coupling.

A fourth isolation feature is to implement the transistors of the core driver in a "deep well" technology such as a deep N well technology. A deep well technology embeds active devices in a well of a first dopant polarity (e.g., P). Deeper within the substrate the first well is embedded within a larger well of opposite polarity (e.g., N) which is itself embedded within a substrate of first dopant polarity (e.g., P). The junctions of opposite polarity effectively create noise barriers between the active devices and the substrate. In some embodiments active devices may also reside within the larger well.

A fifth isolation feature recognizes that the high currents generated by the core drive circuit may generate hot carriers that induce photon generation. The generation of photons, in turn, may interfere with the operation of the sensor array. As such, in one embodiment, one of the metallization layers of the integrated circuit is used to form a wide/large surface area of solid conductive material (e.g., metal) above the core driver circuit. The large conductive region above the core driver acts as a shield that should substantially prevent any photons generated by the core driver **301** from reaching other circuits such as the pixel array.

FIG. 3c shows an embodiment of the power control circuit **302**. As observed in FIG. 3c, the power control circuit **302** includes a finite state machine **330**. As is known in the art a finite state machine **330** typically includes combinatorial logic **331** in front of a register **332** where the register state feeds back to the combinatorial logic **331** and where the combinatorial logic **331** also receives another independent input **333**. In an embodiment, the combinatorial logic **331** is implemented with a look-up table (e.g., implemented with, e.g., content addressable register or memory cells). In other embodiments the combinatorial logic **331** may be implemented with hardwired logic circuits or a combination of a look-up table and hardwired logic implementations.

The register state corresponds to the output of the power control circuit **302** and defines which core driver slices are to be enabled. The independent input **333** provided to the combinatorial logic **331** of the finite state machine corresponds to a photodetector current. Here, the light source array is assumed to include a photodiode that provides an output signal that is proportional to the actual intensity of the light that the light source array is emitting (or, given that the optical signal is in the form of a periodic signal, the average

or the root-mean-square (RMS) of the photocurrent may be utilized). The photodetector signal is converted to digital form by an ADC circuit **334** and provided to the combinatorial logic **331**. The combinatorial logic **331** determines a number of core driver slices to enable as a function of the current number of core driver slices that are enabled and the current photodetector current.

In alternate implementations the finite state machine may be replaced with a more traditional controlled feedback loop having a loop filter that generates a signal whose value indicates the number of slices to enable by integrating an offset signal generated from, e.g., a desired optical power signal and an actual optical power signal derived from the photodetector signal. The traditional feedback loop may be implemented with digital and/or analog circuits.

Notably, the power control circuit also includes an override multiplexer **335** to effectively over-ride the determined number of slices from the finite state machine and, instead, provide a more customized indication of the number of slices to enable. The over-ride can be used, e.g., to set a stronger optical output signal than is typical to simulate the illuminator being closer to an object of interest than it actually is, or, set a weaker optical output signal than is typical to simulate the presence of the illuminator being farther away from an object of interest than it actually is.

The customized number of slices may be provided directly from configuration register space, or, may be provided from a look up table (LUT), hardwired logic or other circuitry **335** that determines the correct number of core driver slices to enable in response to a user provided value for any of the following in configuration register space: 1) optical output power; 2) simulated additional distance away; 3) simulated additional distance closer. The configuration register space may also include an "override enable" parameter that is used to set the channel select input of the override multiplexer **335** (such that the user provided value is used if the override is enabled).

FIG. 4 shows clocking circuitry for the laser driver circuit and pixel array. The clocking circuitry of FIG. 4 may also provide clock signals to the ADC circuitry. As observed in FIG. 4 the clocking circuitry can be viewed as a component of the timing and control circuitry **104**, **204** of FIGS. 1a,b and 2.

As observed in FIG. 4 the clocking circuitry includes a phase locked loop (PLL) circuit **410** that acts as a clock source. The clock signal output of the PLL is coupled to an IQ block **411** that generates four different phases of the PLL clock signal (0°, 90°, 180° and 270°). All four phased clock signals are routed to the pixel array and a phase interpolator **414**. The phase interpolator **414** provides the clock signal **415** that is directed to the core drive circuit as a modulation signal. The phase interpolator **414** is part of a delay locked loop (DLL) that varies the phase positioning of the clock signal **415** in order to eliminate timing skew (phase mismatch) between the clock signals **416** that are directed to the pixel array and the clock signal **415** that is directed to the core driver.

Here, as discussed above, time-of-flight techniques measure the difference in time between when light is flashed by the illuminator and when its reflection is sensed at the pixel array. Any unaccounted for difference between these times is reproduced as error or inaccuracy in the time-of-flight measurement and the profile distance information that is determined from it. As such, controlling skew between the clock signal **312**, **412** that is presented to the driving transistors within the core driver and the clocks **416** that are

provided to the pixel array have a direct effect on the accuracy of the time-of-flight measurement.

As such, the DLL includes a phase detector **417** that compares the phase difference between the clock signal that is provided to the driving transistors **312**, **412** of the core driver circuit slices and the 0° phase clock signal **416_1** that is directed to the pixel array. In response to any difference in phase between the two, the phase detector **417** generates an offset signal that indicates a corrective direction by the phase interpolator **414** that will reduce the offset. In an alternative implementation, rather than use the output from buffer **313** as an input to phase detector **417**, an output is taken further downstream from buffer **313** such as core driver output **318**. Because core driver output **318** may include some additional propagation delay that is imposed in the drive signal beyond buffer **313**, tapping the drive signal at core driver output **318** is actually a more accurate signal in terms of the timing edges of the emitted optical signal. In an even further implementation, a “dummy slice” may be coupled anywhere downstream from core input **315** to “mimic” the light source drive signal or emitted optical output signal. For example, the core driver **301** may include a “duplicate” set of fan-up, inverting buffer, driver slice(s) and “dummy load” circuitry (the later to represent the load of the VCSEL or LED light sources) to craft a signal that should be nearly identical to the signal received by the light sources or the actual emitted optical power.

The offset signal from the phase detector **417** is provided to a loop filter **418**. The loop filter **418** integrates the offset signal to generate a control signal to the phase interpolator **414** that adjusts the phase of the clock signal **415** that is provided to the core driver circuit that corrects for the previously detected offset. Ideally, a steady state is reached in which there is no phase difference between the signal that is provided to the driver transistors and the 0° phase signal **416_1** that is sent to the pixel array. Any other time difference between the actual emission of the light from the light source and the phase of the signal that is provided to the drive transistors is apt to be fixed and/or an otherwise determinable from, e.g., one or more propagation delays and light source response times that can be adjusted for as a fixed offset.

The DLL path to the phase interpolator **414** is also intercepted by an override multiplexer **419** that allows a user to set, e.g., in configuration register space **408**, an adjustment to the output of the loop filter **418**. For example, if the output of the loop filter **418** is a voltage level that the phase interpolator **414** uses to set the phase of clock signal **415**, circuit **420** may increase or decrease this voltage level in increments according to a programmed value from configuration register space **408**. Here, the ability to adjust the loop filter output voltage up or down essentially permits the user to impose phase lag or phase lead to clock signal **415** relative to the actual loop filter setting, which, in turn, corresponds to the deliberate imposition of “offset” into the time-of-flight measurement. In various implementations the phase interpolator **414** may receive a digital word as its control signal rather than an analog signal. As such, the loop filter **418** may be implemented as a digital circuit (e.g., a digital accumulator or finite state machine). Likewise circuit **420** may be implemented as a digital circuit (e.g., a digital adder/subtractor) to digitally alter the loop filter output.

Similar to the optical power override discussed above with respect to FIG. 3c, the deliberate imposition of offset into the phase of clock signal **415** can be used to simulate the camera system being closer to or farther from an object of interest. More specifically, both the optical power over ride

and the DLL over ride can be used together to simulate the camera being some distance from an object other than its actual distance. That is, by lessening the optical power and imposing additional delay to clock signal **415**, the Z pixels of the RGBZ sensor will receive signals of reduced intensity and later in time as if the camera were farther away from an object than it actually is. By contrast, by increasing the optical power and moving the delay of clock signal **415** earlier in time, the Z pixels of the RGBZ sensor will receive signals of enhanced intensity earlier in time as if the camera were closer to an object than it actually is.

Here, it is pertinent to recognize some alternative embodiments to imposing a simulated distance between the light source and an object that is different than an actual distance between the light source and the object. Embodiments discussed so far include adjusting the amplitude and phase of the light source drive signal. Conceivably, a stronger optical signal from a closer object can be simulated by increasing the gain of the depth pixels to capture more charge and therefore generate a higher amplitude signal from the depth pixels. Likewise, a weaker optical signal from an object that is farther away can be simulated by decreasing the gain of the depth pixels to capture less charge and therefore generate a lower amplitude signal from the depth pixels.

Any combination of these techniques may be used to realize the desired simulated distance. As such, various embodiments may include a depth pixel gain adjustment circuit responsive to simulated distance configuration settings to accordingly adjust the gain of the depth pixels.

Additionally a phase interpolator circuit may be used to drive the depth pixel clock signals (e.g., instead of the light source drive signal) to impose phase adjustments to the depth pixel clock signals to realize the simulated distance. As such, more generally, the relative phases of the light source driver signal and the depth pixel clocks may be adjusted to be closer together in time to simulate an object that is closer, and, the relative phases of the light source driver signal and the depth pixel clocks may be adjusted to be farther apart in time to simulate an object that is farther away.

The programmable register space **408** for changing the delay of clock signal **415** may accept any of: 1) a value that specifies a specific change to be made to the loop filter output; 2) simulated additional distance away; 3) simulated additional distance closer. Items 2) and 3) above may be the same configuration space that is used to set the optical power override. In the case of items 2) and 3) above, circuit **420** includes circuitry to determine the correct adjustment to be made to the loop filter output based on the desired simulated distance. In an embodiment, items 2) and 3) can specify the simulated distances in specific increments and circuit **420** adjusts the loop filter output in increments.

In an embodiment, the loop filter **418** is implemented as an analog or mixed signal component that provides the phase interpolator control signal as an analog signal (e.g., a voltage). In another embodiment, the loop filter **418** is implemented as a finite state machine that controls the interpolator with a digital value. In the former case, circuit **420** adjusts the level of the analog signal, in the later case circuit **420** adds/subtracts to/from the digital value. Configuration registers **408** may also include register space that determines whether the DLL circuit is to operate with or without adjustments from circuit **420**. As observed in FIG. 4, the multiplexer **419** may include an input to receive a phase interpolator control input directly from configuration register space **408** without any component from the loop

11

filter and circuit **420**. The channel select input of multiplexer **419** is established in response. In a further embodiment, parameters of the loop filter **418** itself (e.g., time constant, pole frequency, finite state machine combinatorial logic look-up table values, etc.) can be configured from registers **408**.

The timing and control circuitry of FIG. **4** may also generate other timing and control signals such as timing and control signals for the ADC circuits that digitize analog signals from the RGB visible image capture pixels of the pixel array as well as RGB visible image capture pixels themselves. For simplicity the circuitry used to generate these timing and control signals are not shown in FIG. **4**.

FIG. **5a** shows a first methodology that can be performed by embodiments of the integrated image sensor and light source driver described above. As observed in FIG. **5a**, the first methodology includes performing the following within a same semiconductor chip package: generating a drive signal for a light source; responding to light generated from the drive signal and reflected from an object to generate analog depth profile information for the object; and, digitizing the analog depth profile information.

FIG. **5b** shows a second methodology that can be performed by embodiments of the integrated image sensor and light source driver described above. As observed in FIG. **5b** the second methodology includes receiving into configuration register space configuration information to simulate a distance between a light source and an object that is different than an actual distance between the light source and the object **511**. The method also includes generating with a light source driver a light source drive signal **512**. The method also includes sensing with depth capture pixels light that was generated with the light source drive signal and reflected from an object, wherein, relative phases of the light source drive signal and a clock that is directed to the depth capture pixels are adjusted to realize the simulated distance and wherein an amplitude of signals sensed with said depth capture pixels are adjusted to realize the simulated distance **513**.

FIGS. **6a** and **6b** show alternate embodiments of an integrated image sensor and light source driver. As observed in FIG. **6a**, the ADC circuitry **603** is on the same upper semiconductor die **610** as the pixel array **601** instead of being on the lower semiconductor die **602** having the light source driver circuit **605**. As observed in FIG. **6b**, the upper semiconductor die **610** is a complete image sensor having the pixel array **601**, ADC circuitry **603** and timing and control circuitry **604**. The lower semiconductor die **610** has the light source driver circuitry **605**. Still other embodiments may have different portions of any of the ADC circuitry, timing and control circuitry and light source driver on both the upper and the lower semiconductor die.

FIG. **7** shows an integrated traditional camera and time-of-flight imaging system **700**. The system **700** has a connector **701** for making electrical contact, e.g., with a larger system/mother board, such as the system/mother board of a laptop computer, tablet computer or smartphone. Depending on layout and implementation, the connector **701** may connect to a flex cable that, e.g., makes actual connection to the system/mother board, or, the connector **701** may make contact to the system/mother board directly.

The connector **701** is affixed to a planar board **702** that may be implemented as a multi-layered structure of alternating conductive and insulating layers where the conductive layers are patterned to form electronic traces that support the internal electrical connections of the system **700**. Through the connector **701** commands are received from the

12

larger host system such as configuration commands that write/read configuration information to/from configuration registers within the camera system **700**.

An RGBZ image sensor and light source driver **703** are integrated into a same semiconductor die package that is mounted to the planar board **702** beneath a receiving lens **702**. The RGBZ image sensor includes a pixel array having different kinds of pixels, some of which are sensitive to visible light (specifically, a subset of R pixels that are sensitive to visible red light, a subset of G pixels that are sensitive to visible green light and a subset of B pixels that are sensitive to blue light) and others of which are sensitive to IR light. The RGB pixels are used to support traditional "2D" visible image capture (traditional picture taking) functions. The IR sensitive pixels are used to support 3D depth profile imaging using time-of-flight techniques. Although a basic embodiment includes RGB pixels for the visible image capture, other embodiments may use different colored pixel schemes (e.g., Cyan, Magenta and Yellow). The integrated image sensor and light source driver **703** may also include ADC circuitry for digitizing the signals from the image sensor and timing and control circuitry for generating clocking and control signals for the pixel array, the ADC circuitry and the light source driver circuit.

The planar board **702** may likewise include signal traces to carry digital information provided by the ADC circuitry to the connector **701** for processing by a higher end component of the host computing system, such as an image signal processing pipeline (e.g., that is integrated on an applications processor).

A camera lens module **704** is integrated above the integrated RGBZ image sensor and light source driver **703**. The camera lens module **704** contains a system of one or more lenses to focus received light through an aperture of the integrated image sensor and light source driver **703**. As the camera lens module's reception of visible light may interfere with the reception of IR light by the image sensor's time-of-flight pixels, and, contra-wise, as the camera module's reception of IR light may interfere with the reception of visible light by the image sensor's RGB pixels, either or both of the image sensor's pixel array and lens module **703** may contain a system of filters arranged to substantially block IR light that is to be received by RGB pixels, and, substantially block visible light that is to be received by time-of-flight pixels.

An illuminator **705** composed of a light source array **707** beneath an aperture **706** is also mounted on the planar board **701**. The light source array **707** may be implemented on a semiconductor chip that is mounted to the planar board **701**. The light source driver that is integrated in the same package **703** with the RGBZ image sensor is coupled to the light source array to cause it to emit light with a particular intensity and modulated waveform.

In an embodiment, the integrated system **700** of FIG. **7** support three modes of operation: 1) 2D mode; 3) 3D mode; and, 3) 2D/3D mode. In the case of 2D mode, the system behaves as a traditional camera. As such, illuminator **705** is disabled and the image sensor is used to receive visible images through its RGB pixels. In the case of 3D mode, the system is capturing time-of-flight depth information of an object in the field of view of the illuminator **705**. As such, the illuminator **705** is enabled and emitting IR light (e.g., in an on-off-on-off . . . sequence) onto the object. The IR light is reflected from the object, received through the camera lens module **704** and sensed by the image sensor's time-of-flight pixels. In the case of 2D/3D mode, both the 2D and 3D modes described above are concurrently active.

FIG. 8 shows a depiction of an exemplary computing system 800 such as a personal computing system (e.g., desktop or laptop) or a mobile or handheld computing system such as a tablet device or smartphone. As observed in FIG. 8, the basic computing system may include a central processing unit 801 (which may include, e.g., a plurality of general purpose processing cores) and a main memory controller 817 disposed on an applications processor or multi-core processor 850, system memory 802, a display 803 (e.g., touchscreen, flat-panel), a local wired point-to-point link (e.g., USB) interface 804, various network I/O functions 805 (such as an Ethernet interface and/or cellular modem subsystem), a wireless local area network (e.g., WiFi) interface 806, a wireless point-to-point link (e.g., Bluetooth) interface 807 and a Global Positioning System interface 808, various sensors 809_1 through 809_N, one or more cameras 810, a battery 811, a power management control unit 812, a speaker and microphone 813 and an audio coder/decoder 814.

An applications processor or multi-core processor 850 may include one or more general purpose processing cores 815 within its CPU 401, one or more graphical processing units 816, a main memory controller 817, an I/O control function 818 and one or more image signal processor pipelines 819. The general purpose processing cores 815 typically execute the operating system and application software of the computing system. The graphics processing units 816 typically execute graphics intensive functions to, e.g., generate graphics information that is presented on the display 803. The memory control function 817 interfaces with the system memory 802. The image signal processing pipelines 819 receive image information from the camera and process the raw image information for downstream uses. The power management control unit 812 generally controls the power consumption of the system 800.

Each of the touchscreen display 803, the communication interfaces 804-807, the GPS interface 808, the sensors 809, the camera 810, and the speaker/microphone codec 813, 814 all can be viewed as various forms of I/O (input and/or output) relative to the overall computing system including, where appropriate, an integrated peripheral device as well (e.g., the one or more cameras 810). Depending on implementation, various ones of these I/O components may be integrated on the applications processor/multi-core processor 850 or may be located off the die or outside the package of the applications processor/multi-core processor 850.

In an embodiment one or more cameras 810 includes an integrated traditional visible image capture and time-of-flight depth measurement system having an RGBZ image sensor and light source driver integrated in a same semiconductor chip package. Application software, operating system software, device driver software and/or firmware executing on a general purpose CPU core (or other functional block having an instruction execution pipeline to execute program code) of an applications processor or other processor may direct commands to and receive image data from the camera system.

In the case of commands, the commands may include entrance into or exit from any of the 2D, 3D or 2D/3D system states discussed above. Additionally, commands may be directed to configuration space of the integrated image sensor and light source driver to implement any of the configured settings discussed above with respect to FIGS. 1a,b through 6a,b, including but not limited to a configuration that causes the integrated image sensor and light source driver to simulate the camera being closer to or farther from an object in its field of view that the camera actually is.

Embodiments of the invention may include various processes as set forth above. The processes may be embodied in machine-executable instructions. The instructions can be used to cause a general-purpose or special-purpose processor to perform certain processes. Alternatively, these processes may be performed by specific hardware components that contain hardwired logic for performing the processes, or by any combination of programmed computer components and custom hardware components.

Elements of the present invention may also be provided as a machine-readable medium for storing the machine-executable instructions. The machine-readable medium may include, but is not limited to, floppy diskettes, optical disks, CD-ROMs, and magneto-optical disks, FLASH memory, ROMs, RAMs, EPROMs, EEPROMs, magnetic or optical cards, propagation media or other type of media/machine-readable medium suitable for storing electronic instructions. For example, the present invention may be downloaded as a computer program which may be transferred from a remote computer (e.g., a server) to a requesting computer (e.g., a client) by way of data signals embodied in a carrier wave or other propagation medium via a communication link (e.g., a modem or network connection).

In the foregoing specification, the invention has been described with reference to specific exemplary embodiments thereof. It will, however, be evident that various modifications and changes may be made thereto without departing from the broader spirit and scope of the invention as set forth in the appended claims. The specification and drawings are, accordingly, to be regarded in an illustrative rather than a restrictive sense.

The invention claimed is:

1. An apparatus, comprising:

a semiconductor chip package comprising an image sensor, a light source driver circuit and a timing circuit [integrated in a same semiconductor chip package], said image sensor comprising [visible light pixels and] depth pixels, said depth pixels to sense light generated with a light source drive signal, said light source driver circuit comprising an output to provide said light source drive signal, said image sensor comprising an input to receive a first clock signal for said depth pixels, said timing circuit comprising a first output to provide said first clock signal, said light source driver circuit comprising an input to receive a second clock signal for said light source drive signal, and said timing circuit comprising an output to provide said second clock signal.

2. The apparatus of claim 1 wherein *said semiconductor chip package further comprises configuration registers to program said timing circuit [is to be programmed from configuration registers that reside within said semiconductor chip package].*

3. The apparatus of claim 1 wherein *said semiconductor chip package comprises a first semiconductor chip and a second semiconductor chip, and wherein said image sensor is disposed on [a] said first semiconductor chip and at least one of said light source driver circuit and said timing circuit are disposed on [a] said second semiconductor chip.*

4. The apparatus of claim 3 wherein *said first semiconductor chip is stacked on said second semiconductor chip.*

5. The apparatus of claim 4 wherein *said second semiconductor chip further comprises conductive vias within its substrate coupled to conductive balls and/or bumps on a bottom surface of said semiconductor chip package.*

6. The apparatus of claim 1 wherein *said apparatus further comprises analog-to-digital conversion circuitry integrated*

15

within said semiconductor chip package, said analog-to-digital conversion circuitry to digitize analog signals generated by said depth pixels.

7. The apparatus of claim 1 wherein said timing circuit is to generate quadrature clock signals for said image sensor.

8. A method, comprising:

generating a first clock signal and a second clock signal with a timing circuit that is within a semiconductor chip package;

generating a light source drive signal from the first clock signal with a light source driver circuit that is integrated within the semiconductor chip package; *and*

[sensing visible light with visible light pixels of an image sensor that is integrated within the semiconductor chip package; *and*]

generating depth information with depth pixels of [the] an image sensor *that is integrated within the semiconductor chip package*, the generating of the depth information comprising the image sensor receiving the second clock signal and receiving light generated with the light source drive signal.

9. The method of claim 8 further comprising programming configuration registers for said timing circuit that reside within said semiconductor chip package.

10. The method of claim 8 wherein said image sensor is disposed on a first semiconductor chip and at least one of said light source driver circuit and said timing circuit is disposed on a second semiconductor chip *and the method further comprises transmitting said first clock signal and said second clock signal from the second semiconductor chip to the first semiconductor chip*.

11. The method of claim 10 wherein said first semiconductor chip is stacked on said second semiconductor chip.

12. The method of claim 11 wherein said second semiconductor chip further comprises conductive vias within its substrate coupled to conductive balls and/or bumps on a bottom surface of said semiconductor chip package.

13. The method of claim 8 further comprising performing analog-to-digital conversion within said semiconductor chip package to digitize analog signals generated by said depth pixels.

14. A computing system, comprising:

[a plurality of general purpose] *one or more* processors; a system memory;

a memory controller coupled between the system memory and the [general purpose] *one or more* processors; *and a semiconductor chip package comprising* an image sensor, a light source driver circuit and a timing circuit [integrated in a same semiconductor chip package].

16

said image sensor comprising [visible light pixels and] depth pixels, said depth pixels to sense light generated with a light source drive signal, said light source driver circuit comprising an output to provide said light source drive signal, said image sensor comprising an input to receive a first clock signal for said depth pixels, said timing circuit comprising a first output to provide said first clock signal, said light source driver circuit comprising an input to receive a second clock signal for said light source drive signal, *and* said timing circuit comprising an output to provide said second clock signal.

15. The computing system of claim 14 wherein *said semiconductor chip package further comprises configuration registers to program* said timing circuit [is to be programmed from configuration registers that reside within said semiconductor chip package].

16. The computing system of claim 14 wherein *said semiconductor chip package further comprises a first semiconductor chip and a second semiconductor chip, and wherein* said image sensor is disposed on [a] the first semiconductor chip and at least one of said light source driver circuit and said timing circuit are disposed on [a] the second semiconductor chip.

17. The computing system of claim 16 wherein said first semiconductor chip is stacked on said second semiconductor chip.

18. The computing system of claim 17 wherein said second semiconductor chip further comprises conductive vias within its substrate coupled to conductive balls and/or bumps on a bottom surface of said semiconductor chip package.

19. The computing system of claim 14 [wherein said apparatus further comprises] *further comprising* analog-to-digital conversion circuitry integrated within said semiconductor chip package, said analog-to-digital conversion circuitry to digitize analog signals generated by said depth pixels.

20. The computing system of claim 14 wherein said timing circuit is to generate quadrature clock signals for said image sensor.

21. *The computing system of claim 14, wherein said image sensor further comprises visible light pixels.*

22. *The apparatus of claim 1, wherein said image sensor further comprises visible light pixels.*

23. *The method of claim 8, further comprising: sensing visible light with visible light pixels of the image sensor.*

* * * * *